

EVVOSEMI[®]

THINK CHANGE DO



ESD



TVS



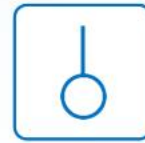
MOS



LDO



Diode



Sensor



DC-DC

Product Specification

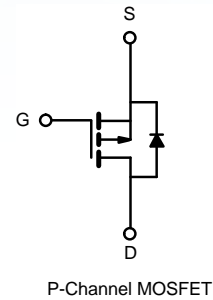
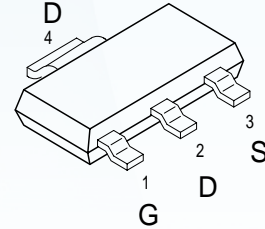
▶ Domestic	Part Number	NDT2955
▶ Overseas	Part Number	NDT2955
▶ Equivalent	Part Number	NDT2955

EV is the abbreviation of name EVVO

-60V P-Channel MOSFET

Features

- $V_{DS} (V) = -60V$
- $I_D = -7A (V_{GS} = -10V)$
 $I_D = -6A (V_{GS} = -4.5V)$
- $R_{DS(ON)} < 55m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 65m\Omega (V_{GS} = -4.5V)$



ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 150\text{ }^\circ\text{C}$)	I_D	$T_C = 25\text{ }^\circ\text{C}$	- 7.0 ^a
		$T_C = 70\text{ }^\circ\text{C}$	- 5.2
		$T_A = 25\text{ }^\circ\text{C}$	- 4.8 ^b
		$T_A = 70\text{ }^\circ\text{C}$	- 4.1 ^b
Pulsed Drain Current	I_{DM}	- 25	A
Avalanche Current Pulse	I_{AS}	- 4.5	
Single Pulse Avalanche Energy	E_{AS}	10.1	
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$	6.9 ^a
		$T_A = 25\text{ }^\circ\text{C}$	3.5 ^b
Maximum Power Dissipation	P_D	$T_C = 25\text{ }^\circ\text{C}$	10.4 ^a
		$T_C = 70\text{ }^\circ\text{C}$	6.6 ^a
		$T_A = 25\text{ }^\circ\text{C}$	2.1 ^b
		$T_A = 70\text{ }^\circ\text{C}$	1.1 ^b
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	33	40	$^\circ\text{C/W}$
Maximum Junction-to-Case	Steady State	R_{thJC}	0.98	1.2	

Notes:

a. Based on $T_C = 25\text{ }^\circ\text{C}$.

b. Surface mounted on 1" x 1" FR4 board.

-60V P-Channel MOSFET

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 60			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = - 250 μA		68		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			- 5.2		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 1.0		- 2.5	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 60 V, V _{GS} = 0 V			- 1	μA
		V _{DS} = - 60 V, V _{GS} = 0 V, T _J = 55 °C			- 10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 25			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 3 A		55		mΩ
		V _{GS} = - 4.5 V, I _D = - 2 A		65		
Forward Transconductance ^a	g _{fs}	V _{DS} = - 15 V, I _D = - 5 A	20			S
Dynamic^b						
Input Capacitance	C _{iss}	V _{DS} = - 25 V, V _{GS} = 0 V, f = 1 MHz		1500		pF
Output Capacitance	C _{oss}			200		
Reverse Transfer Capacitance	C _{rss}			150		
Total Gate Charge	Q _g	V _{DS} = - 30 V, V _{GS} = - 10 V, I _D = - 5 A		38	56	nC
				19	30	
Gate-Source Charge	Q _{gs}	V _{DS} = - 30 V, V _{GS} = - 4.5 V, I _D = - 5 A		9		
Gate-Drain Charge	Q _{gd}			10		
Gate Resistance	R _g	f = 1 MHz		5.2		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 2 V, R _L = 2 Ω I _D ≅ - 5 A, V _{GEN} = - 10 V, R _g = 1 Ω		10	15	ns
Rise Time	t _r			7	15	
Turn-Off Delay Time	t _{d(off)}			70	110	
Fall Time	t _f			40	60	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 6.9	A
Pulse Diode Forward Current ^a	I _{SM}				- 15	
Body Diode Voltage	V _{SD}	I _S = - 3 A		- 1	- 1.5	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = - 5 A, di/dt = 10 A/μs, T _J = 25 °C		45	68	ns
Body Diode Reverse Recovery Charge	Q _{rr}			59	120	nC
Reverse Recovery Fall Time	t _a			29		ns
Reverse Recovery Rise Time	t _b			16		

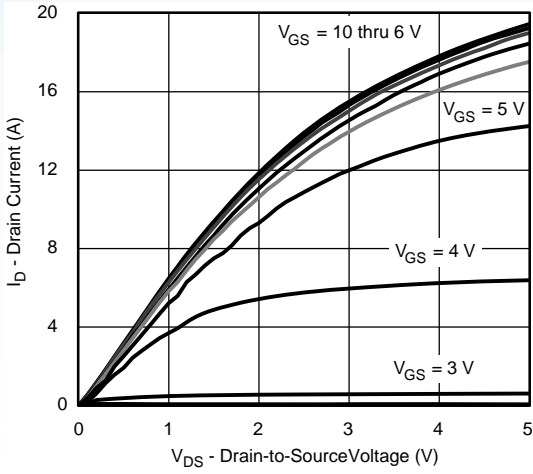
Notes:

- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %.
- b. Guaranteed by design, not subject to production testing.

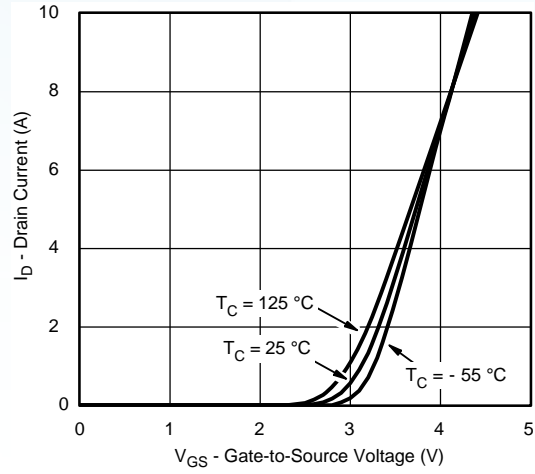
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

-60V P-Channel MOSFET

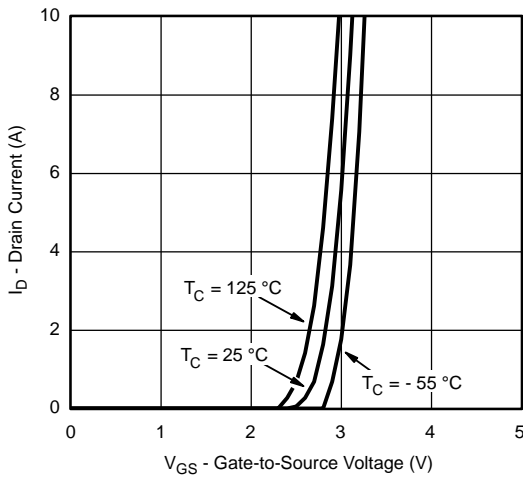
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



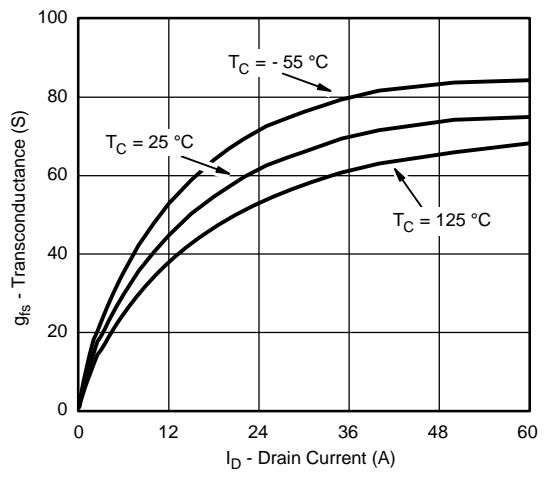
Output Characteristics



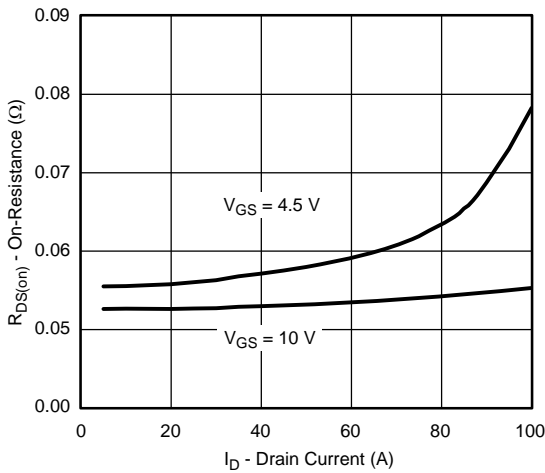
Transfer Characteristics



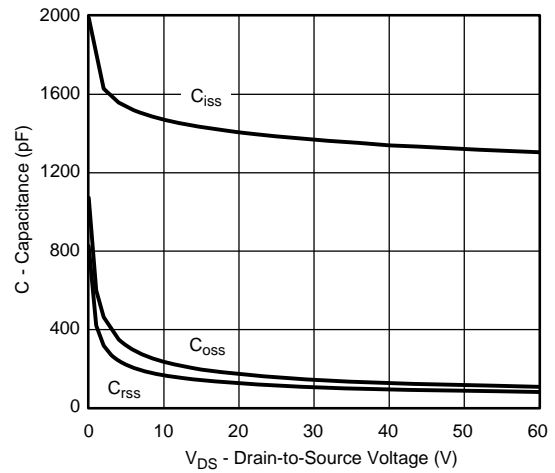
Transfer Characteristics



Transconductance



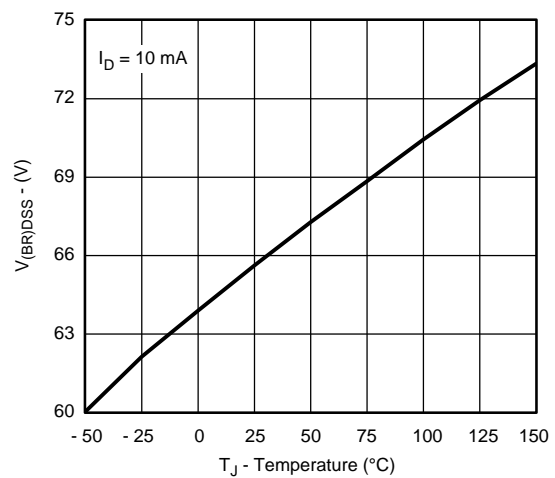
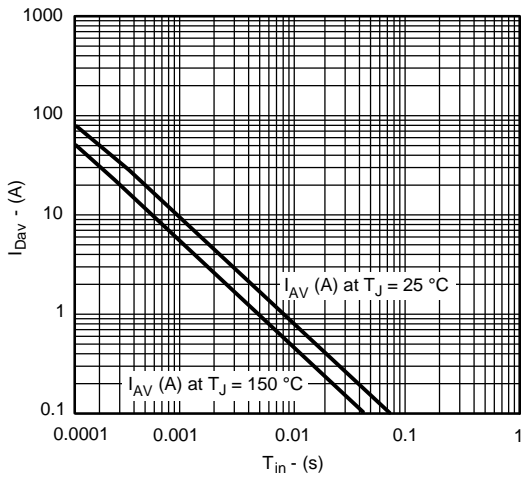
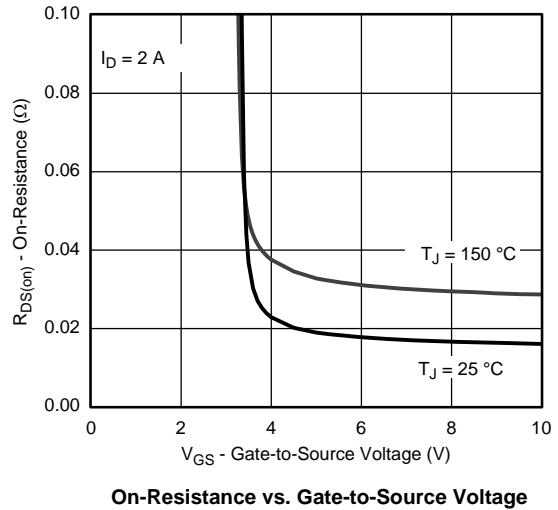
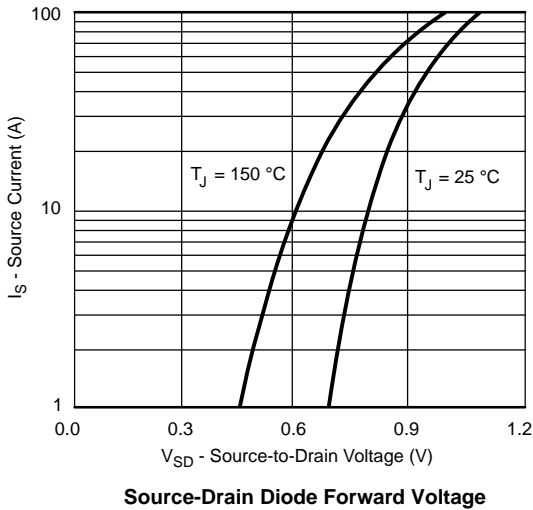
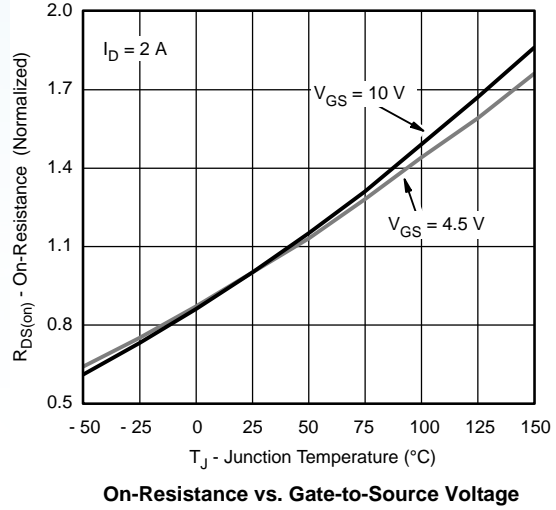
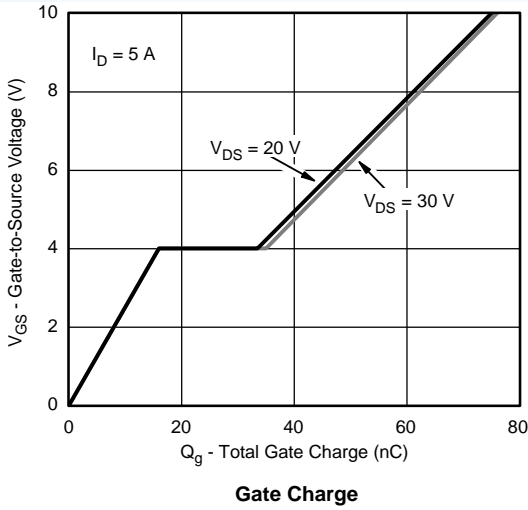
On-Resistance vs. Drain Current



Capacitance

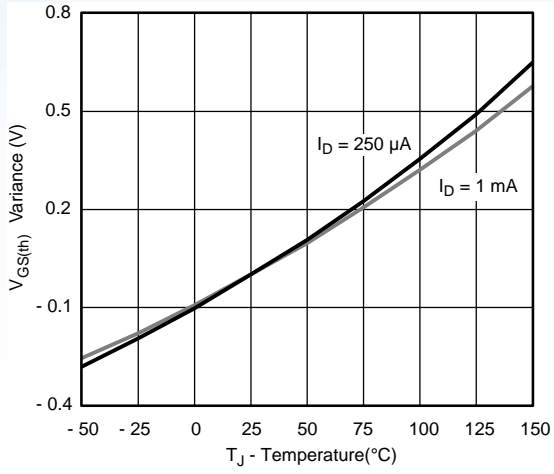
-60V P-Channel MOSFET

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

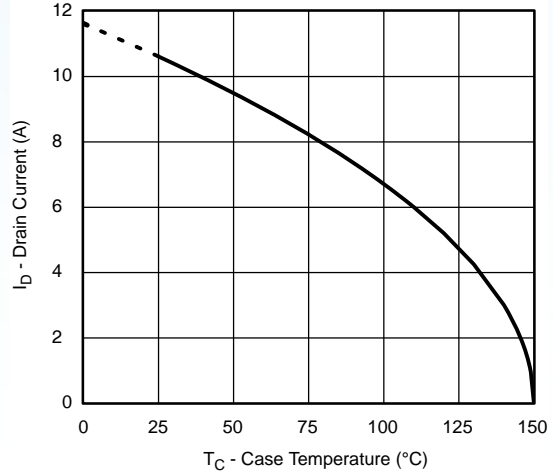


-60V P-Channel MOSFET

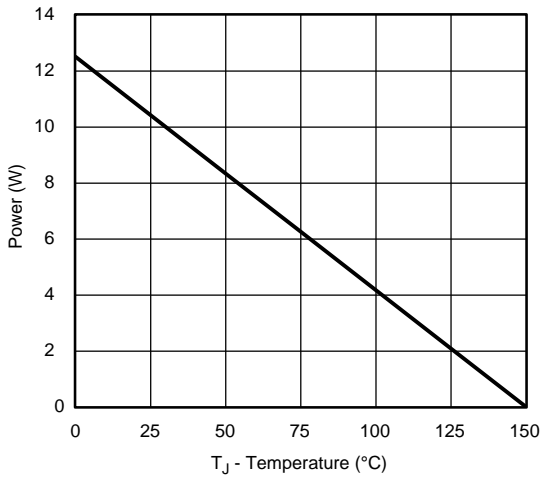
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



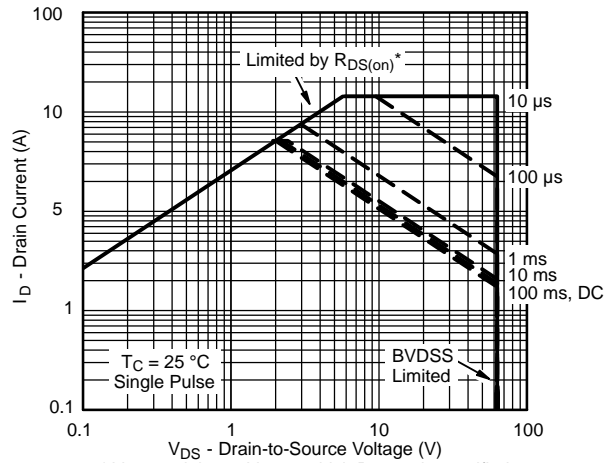
Threshold Voltage



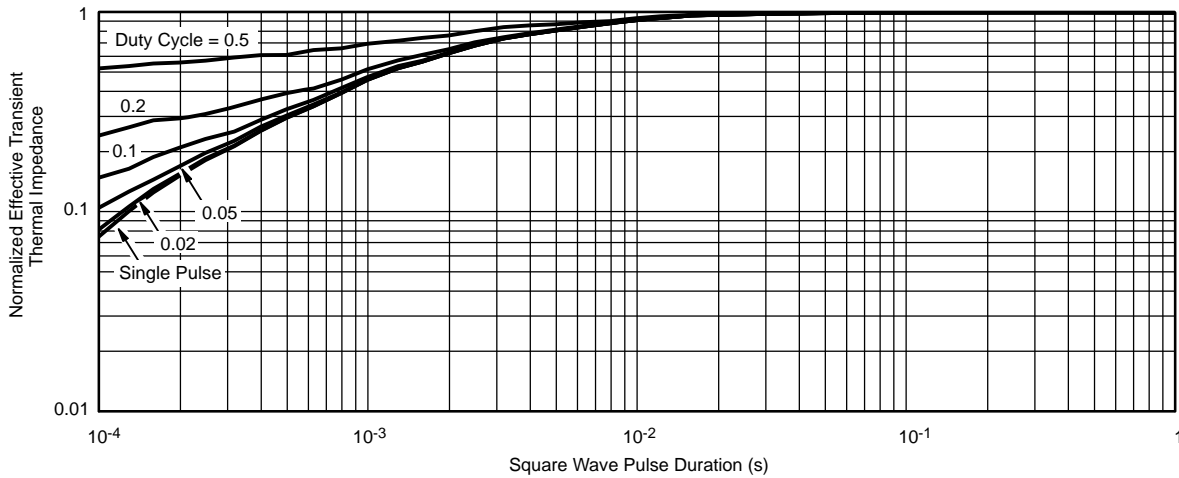
Max. Drain Current vs. Case Temperature



Power Derating, Junction-to-Case



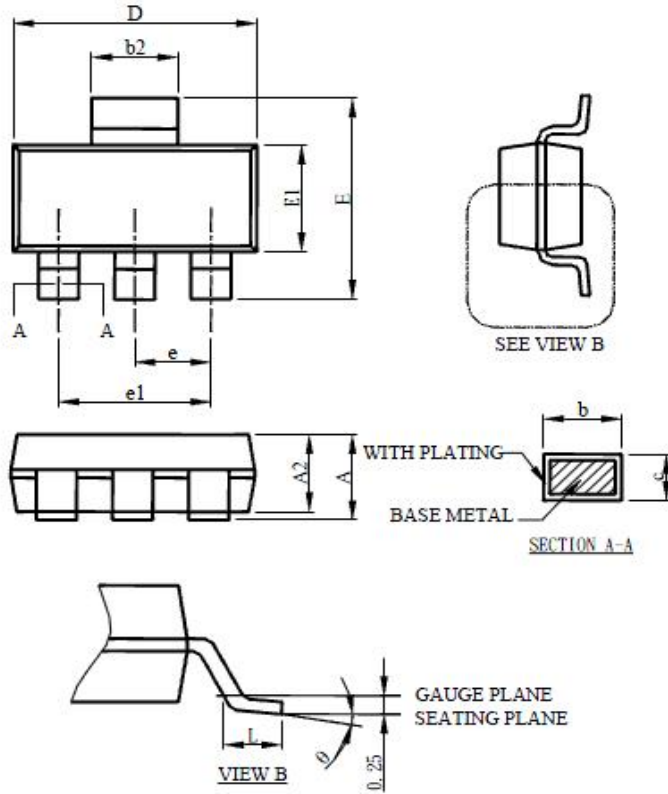
Safe Operating Area, Junction-to-Case



Normalized Thermal Transient Impedance, Junction-to-Case

-60V P-Channel MOSFET

Package Mechanical Data SOT-223



SYMBOL	SOT-223	
	MILLIMETERS	
	MIN.	MAX.
A		1.80
A1	0.02	0.10
A2	1.55	1.65
b	0.68	0.84
b2	2.90	3.10
c	0.23	0.33
D	6.30	6.70
E	6.70	7.30
E1	3.30	3.70
e	2.30 BSC	
e1	4.60 BSC	
L	0.90	
θ	0°	8°

- Note:
1. Refer to JEDEC TO-261AA.
 2. Dimension D and E1 are determined at the outermost extremes of the plastic body exclusive of mold flash, tie bar burrs, gate burrs, and interlead flash, but including any mismatch between the top and bottom of the plastic body.
 3. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.

-60V P-Channel MOSFET**Ordering information**

Order code	Package	Baseqty	Deliverymode
NDT2955	SOT-223	2500	Tape and reel

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